



IGOT60R070D1

600V CoolGaN™ enhancement-mode Power Transistor

Features

- Enhancement mode transistor Normally OFF switch
- Ultra fast switching
- No reverse-recovery charge
- Capable of reverse conduction
- Low gate charge, low output charge
- Superior commutation ruggedness
- Qualified for industrial applications according to JEDEC Standards (JESD47 and JESD22)

Benefits

- Improves system efficiency
- Improves power density
- Enables higher operating frequency
- System cost reduction savings
- Reduces EMI

Applications

Industrial, telecom, datacenter SMPS based on the half-bridge topology (half-bridge topologies for hard and soft switching such as Totem pole PFC, high frequency LLC).

For other applications: review CoolGaN[™] reliability white paper and contact Infineon regional support

Table 1Key Performance Parameters at $T_j = 25$ °C

Parameter	Value	Unit	
V _{DS,max}	600	V	
R _{DS(on),max}	70	mΩ	
Q _{G,typ}	5.8	nC	
I _{D,pulse}	60	A	
Q _{oss} @ 400 V	41	nC	
Q _{rr}	0	nC	



Table 2 Ordering Information

Type / Ordering Code	Package	Marking	Related links
IGOT60R070D1	PG-DSO-20-87	60R070D1	see Appendix A





Gate	9, 10			
Drain	13,14,15,16,17,18			
Kelvin Source	8			
Source	1,2,3,4,5,6,7, heatslug			
not connected	11,12,19,20			

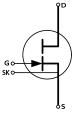




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1 Maximum ratings

at T_j = 25 °C, unless otherwise specified. Continuous application of maximum ratings can deteriorate transistor lifetime. For further information, contact your local Infineon sales office.

Symbol Values Unit **Note/Test Condition** Parameter Min. Typ. Max. Drain source voltage, continuous¹ V_{DS,max} _ _ 600 ٧ $V_{GS} = 0 V$ ٧ $V_{GS} = 0 V$, $I_{DS} = 12.2 mA$ Drain source destructive breakdown 800 V_{DS.bd} voltage ² Drain source voltage, pulsed² $V_{\text{DS},\text{pulse}}$ _ 750 V $T_j = 25 \text{ °C}; V_{GS} \le 0 \text{ V}; \le 1 \text{ hour}$ _ of total time V 650 $T_i = 125 \,^{\circ}C, V_{GS} \le 0 \, V; \le 1 \, hour$ of total time V DC bus voltage = 700 V; turn Switching surge voltage, pulsed² $V_{\text{DS},\text{surge}}$ 750 off V_{DS,pulse} = 750 V; turn on $I_{D,pulse} = 27 \text{ A}; T_i = 105 \text{ °C};$ $f \le 100 \text{ kHz}, t \le 100 \text{ secs}$ (10 million pulses) Continuous current, drain source I_{D} 31 А $T_{c} = 25 \text{ °C}; T_{i} = T_{i, max}$ _ $T_{c} = 100 \text{ °C}; T_{i} = T_{i, max}$ 20 14 $T_{c} = 125 \text{ °C}; T_{i} = T_{i, \max}$ Pulsed current, drain source ³⁴ $T_c = 25 \,^{\circ}C; I_c = 26.1 \,\text{mA};$ А D,pulse _ 60 See Figure 3; $T_c = 125 \text{ °C}; I_g = 26.1 \text{ mA};$ _ 35 А Pulsed current, drain source ⁴⁵ D,pulse See Figure 4; Gate current, continuous ⁴⁵⁶ 20 $T_j = -55 \,^{\circ}C \text{ to } 150 \,^{\circ}C;$ I_{G,avg} mΑ _ _ Gate current, pulsed ⁴⁶ $T_i = -55 \,^{\circ}C$ to 150 $\,^{\circ}C$; 2000 mΑ I_{G,pulse} $t_{PULSE} = 50 \text{ ns}, f=100 \text{ kHz}$ V $T_i = -55 \,^{\circ}C$ to 150 $\,^{\circ}C$; Gate source voltage, continuous⁶ V_{GS} -10 _ Gate source voltage, pulsed ⁶ -25 _ V $T_i = -55 \,^{\circ}C \text{ to } 150 \,^{\circ}C;$ V_{GS,pulse} $t_{PULSE} = 50 \text{ ns}, f = 100 \text{ kHz};$ open drain $T_{c} = 25 \,^{\circ}C$ **Power dissipation** P_{tot} 125 W --°C Operating temperature Ti -55 _ 150

Table 3 Maximum ratings

 $^{^1}$ $\,$ All devices are 100% tested at I_{DS} = 12.2 mA to assure V_{DS} \geq 800 V $\,$

² Provided as measure of robustness under abnormal operating conditions and not recommended for normal operation

 $^{^{\}scriptscriptstyle 3}$ $\,$ Limits derived from product characterization, parameter not measured during production

 $^{^{4} \}qquad \text{Ensure that average gate drive current, } I_{G,avg} \text{ is} \leq 20 \text{ mA. Please see figure 27 for } I_{G,avg}, I_{G,pulse} \text{ and } I_{G} \text{ details}$

 ⁵ Parameter is influenced by rel-requirements. Please contact the local Infineon Sales Office to get an assessment of your application
 ⁶ We recommend using an advanced driving technique to optimize the device performance. Please see gate drive application note for details

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Storage temperature	T _{stg}	-55	-	150	°C	Max shelf life depends on storage conditions.
Drain-source voltage slew-rate	dV/dt			200	V/ns	

2 Thermal characteristics

Table 4Thermal characteristics

Parameter	Symbol	Values		Values		Note/Test Condition
		Min.	Тур.	Max.		
Thermal resistance, junction-case	R_{thJC}	-	-	1	°C/W	
Reflow soldering temperature	T _{sold}	-	-	260	°C	MSL3



3 Electrical characteristics

at T_i = 25 °C, unless specified otherwise

Table 5Static characteristics

Parameter	Symbol		Values		Values		Values		Unit	Note/Test Condition
		Min.	Тур.	Max.						
Gate threshold voltage	V _{GS(th)}	0.9	1.2	1.6	V	I _{DS} = 2.6 mA; V _{DS} = 10 V; T _j =25 °C				
		0.7	1.0	1.4		I _{DS} = 2.6 mA; V _{DS} = 10 V; T _j =125 °C				
Gate-Source reverse clamping voltage	$V_{GS,clamp}$	-	-	-8	V	I _{GSS} = -1 mA				
Drain-Source leakage current		-	1	100	μA	$V_{DS} = 600 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$				
	I _{DSS}	-	20	-		V_{DS} = 600 V; V_{GS} = 0 V; T_j = 150 °C				
Drain-Source leakage current at application conditions ¹	I _{DSSapp}	-	60	-	μA	V_{DS} = 400 V; V_{GS} = 0 V; T_j = 125 °C				
Drain-Source on-state resistance		-	0.055	0.070	Ω	I _G = 26.1 mA; I _D = 8 A; T _j = 25 °C				
	R _{DS(on)}	-	0.100	-		I _G = 26.1 mA; I _D = 8 A; T _j = 150 °C				
Gate resistance	$R_{G,int}$	-	0.78	-	Ω	LCR impedance measurement; f = f _{res} ; open drain;				

Table 6Dynamic characteristics

Parameter	Symbol		Value	S	Unit	Note/Test Condition
		Min.	Тур.	Max.		
Input capacitance	C _{iss}	-	380	-	pF	$V_{GS} = 0 V; V_{DS} = 400 V;$ f = 1 MHz
Output capacitance	C _{oss}	-	72	-	pF	$V_{GS} = 0 V; V_{DS} = 400 V;$ f = 1 MHz
Reverse Transfer capacitance	C _{rss}	-	0.3	-	pF	$V_{GS} = 0 V; V_{DS} = 400 V;$ f = 1 MHz
Effective output capacitance, energy related ²	C _{o(er)}	-	80	-	pF	V _{DS} =0 to 400 V
Effective output capacitance, time related ³	C _{o(tr)}	-	102.5	-	pF	$V_{GS} = 0 V$; $V_{DS} = 0$ to 400 V; Id = const
Output charge	Q _{oss}	-	41	-	nC	V _{DS} =0 to 400 V
Turn- on delay time	t _{d(on)}	-	10	-	ns	see Figure 23
Turn- off delay time	t _{d(off)}	-	14	-	ns	see Figure 23
Rise time	t _r	-	8	-	ns	see Figure 23
Fall time	t _f	-	15	-	ns	see Figure 23

 $^{\rm 1}$ Parameter represents end of use leakage in applications

 2 C_{o(er)} is a fixed capacitance that gives the same stored energy as Coss while VDS is rising from 0 to 400 V

 3 C_{o(tr)} is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 400 V

Downloaded from Arrow.com.



Table 7Gate charge characteristics

Parameter	Symbol	Values		Values		Unit	Note/Test Condition
		Min.	Тур.	Max.			
Gate charge	Q _G	-	5.8	-	nC	$I_{GS} = 0 \text{ to } 10 \text{ mA}; V_{DS} = 400 \text{ V};$ $I_{D} = 8 \text{ A}$	

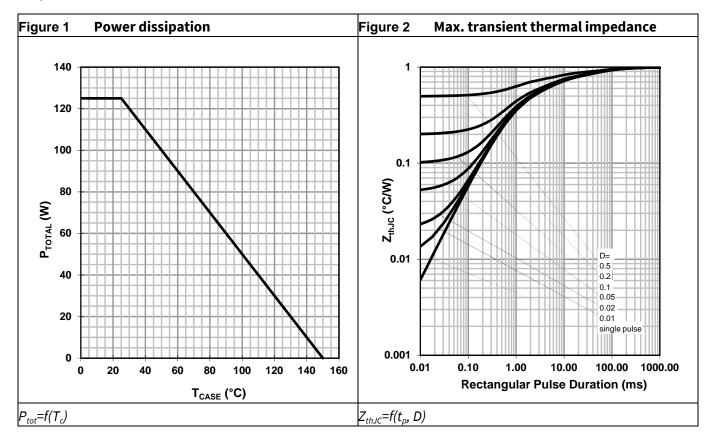
Table 8 Reverse conduction characteristics

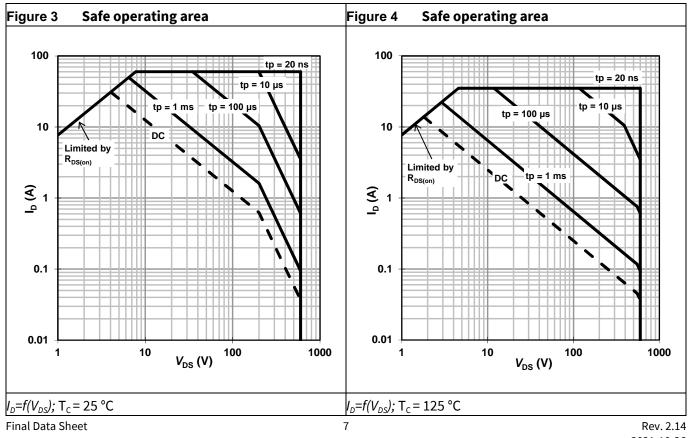
Parameter	Symbol	Values			Unit	Note/Test Condition	
		Min.	Тур.	Max.			
Source-Drain reverse voltage	V _{SD}	-	2.2	2.5	V	$V_{GS} = 0 V; I_{SD} = 8 A$	
Pulsed current, reverse	I _{S,pulse}	-	-	60	А	I _G = 26.1 mA	
Reverse recovery charge	Q _{rr} ¹	-	0	-	nC	I _s = 8 A, V _{DS} = 400 V	
Reverse recovery time	t _{rr}	-	0	-	ns		
Peak reverse recovery current	I _{rrm}	-	0	-	Α		



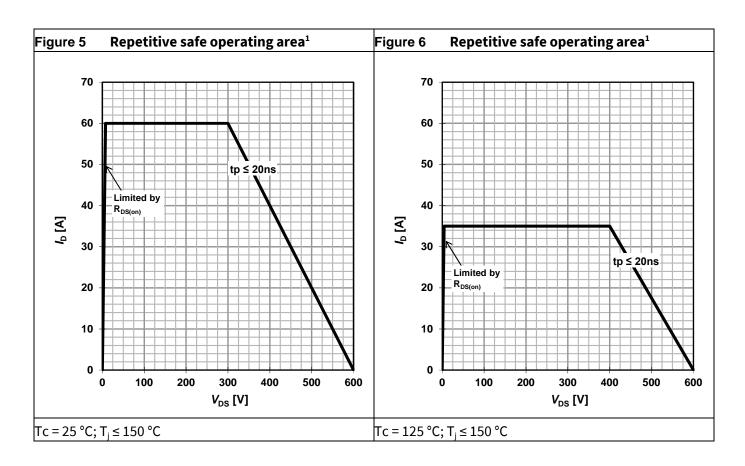
Electrical characteristics diagrams 4

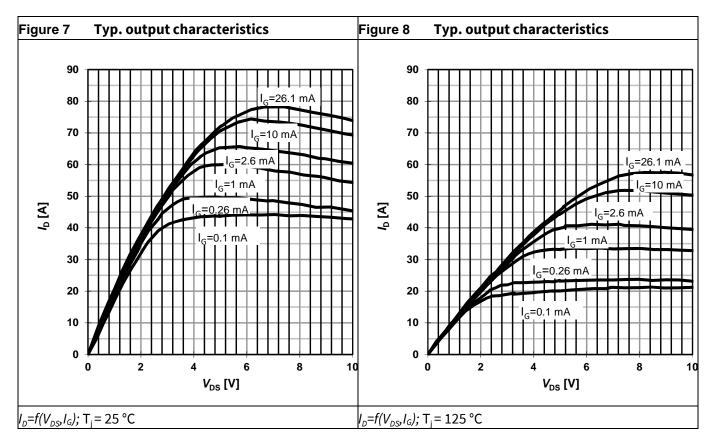
at T_i = 25 °C, unless specified otherwise





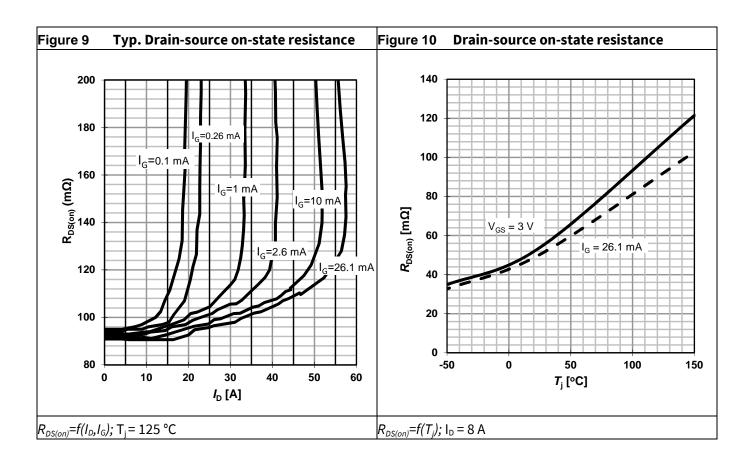


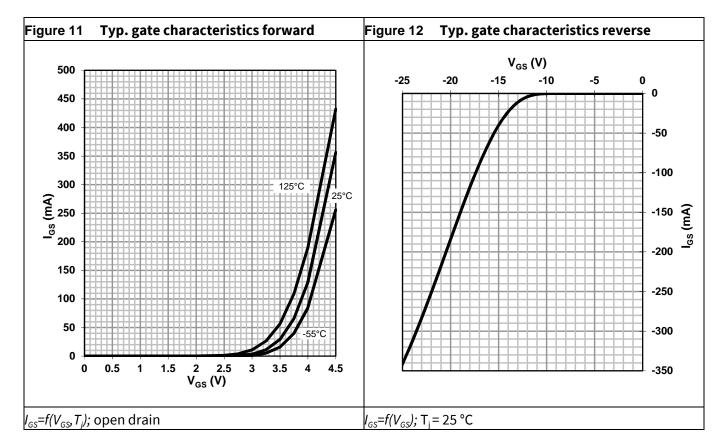




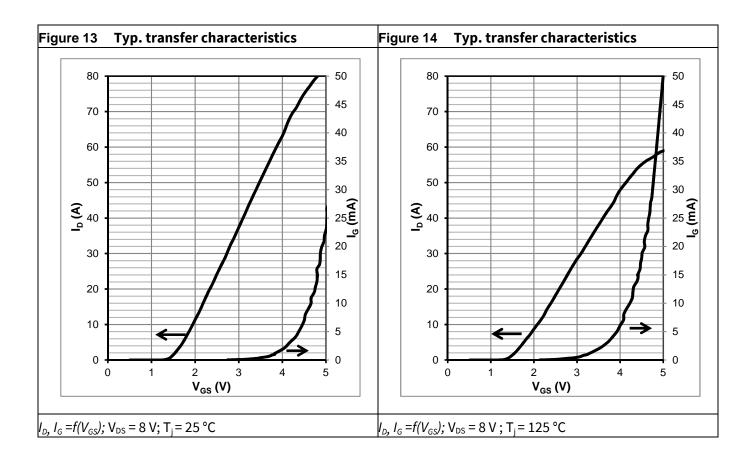
¹ Parameter is influenced by rel-requirements. Please contact the local Infineon Sales Office to get an assessment of your application. **Final Data Sheet** 8 Rev. 2.14

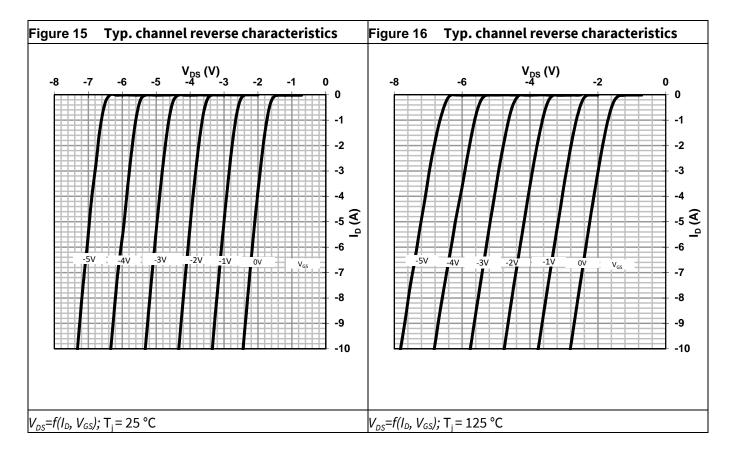






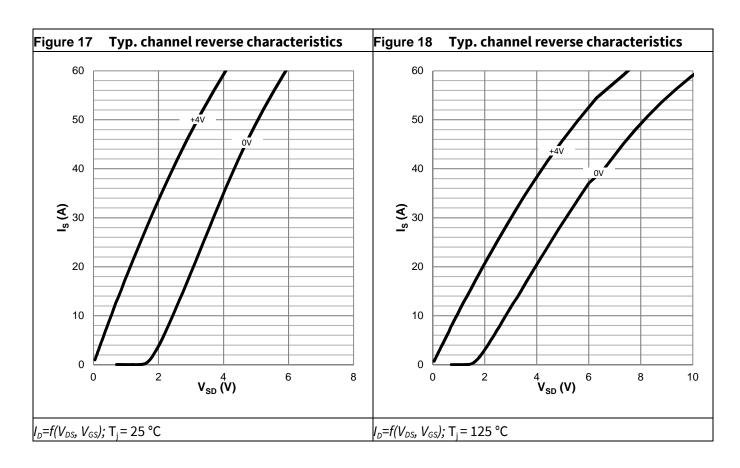


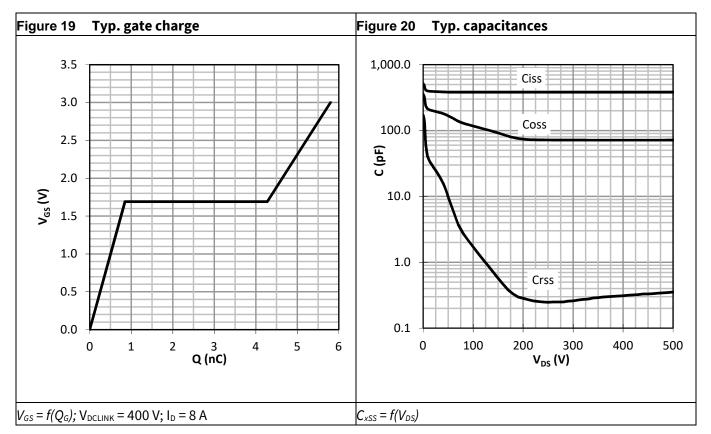




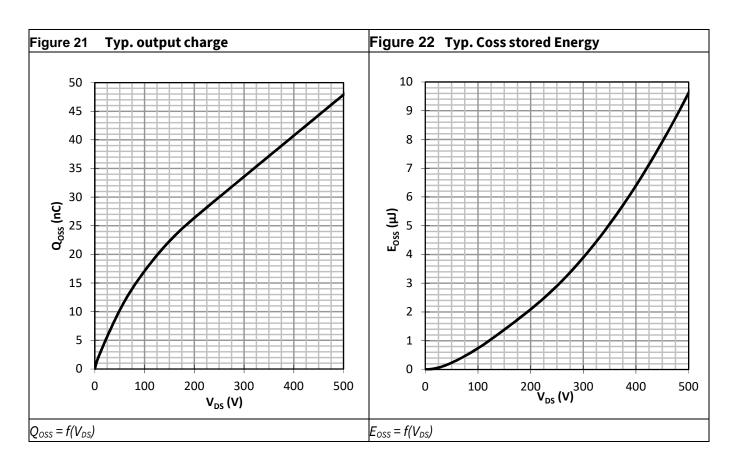






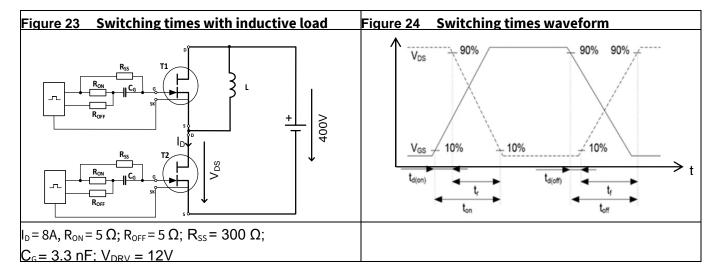


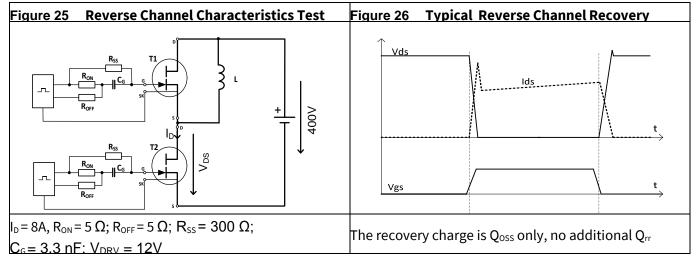


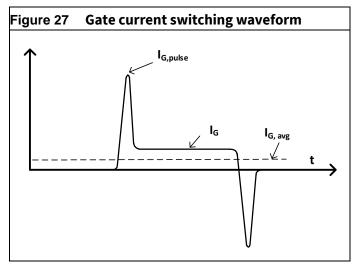




5 Test Circuits







Final Data Sheet



6 Package Outlines

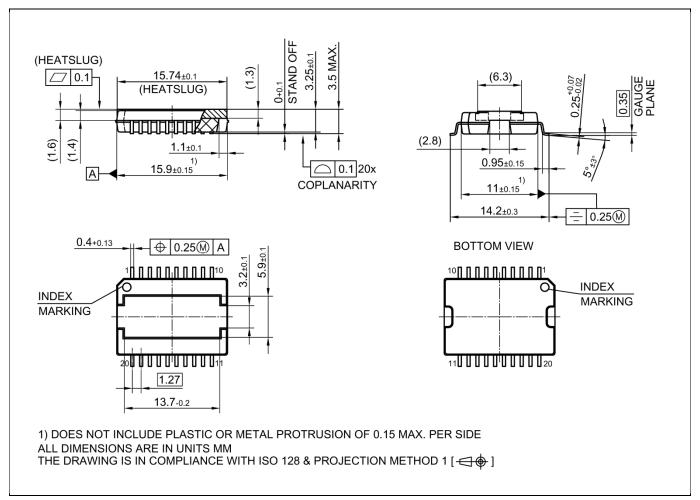


Figure 28 PG-DSO-20-87 Package Outline, dimensions (mm)

Final Data Sheet



7 Appendix A

Table 9 Related links

- IFX CoolGaN[™] webpage: <u>www.infineon.com/why-coolgan</u>
- IFX CoolGaN[™] reliability white paper: <u>www.infineon.com/gan-reliability</u>
- IFX CoolGaN[™] gate drive application note: <u>www.infineon.com/driving-coolgan</u>
- IFX CoolGaN[™] applications information:
 - o <u>www.infineon.com/gan-in-server-telecom</u>
 - o <u>www.infineon.com/gan-in-wirelesscharging</u>
 - o <u>www.infineon.com/gan-in-audio</u>
 - www.infineon.com/gan-in-adapter-charger



8 Revision History

Major changes since the last revision

Revision	Date	Description of changes
2.0	2018-04-24	Final version release
2.1	2018-07-23	Updated DSO-20-87 package outline drawing in page14
2.11	2018-10-12	Updated application section; added Appendix A and Fig. 27; updated maximum rating table footnotes, switching times and figures
2.12	2020-01-16	Added V _{DS,bd} , V _{DS,pulse} , V _{DS,surge} specifications in maximum ratings table of page3
2.13	2021-04-27	Updated T _{sold} specification to 260°C in table 4; updated I _{GSS} specification at 125°C to -2 mA in table 5; updated switching times and related test conditions
2.14	2021-10-26	Replaced I _{GSS} specification with V _{GS, clamp} in table 5

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